

# BCT4227 High-Speed DPDT Analog Switch

#### **FEATURES**

- ♦ V<sub>CC</sub> Operating Range: 1.65V to 4.5V
- ♦ Rail-to-Rail Signal Range
- ♦ ON-Resistance Matching: 0.05 Ω (TYP)
- ON-Resistance Flatness: 0.08Ω (TYP)
- + High Off Isolation: 58dB at 10MHz
- 54dB (10MHz) Crosstalk Rejection Reduces
  Signal Distortion
- Break-Before-Make Switching
- ◆ -3dB Bandwidth: 720MHz
- ◆ Extended Industrial Temperature Range: -40°C to 85°C
- Packaging (Pb-free & Green available)

## APPLICATIONS

Cell Phones PDAs Portable Instrumentation Differential Signal Data Routings USB 2.0 Signal Routing

#### **GENERAL DESCRIPTION**

The BCT4227 is a high bandwidth, fast double-pole double-throw (DPDT) analog switch. Its wide bandwidth and low bit-to-bit skew allow it to pass high-speed differential signals with good signal integrity. Each switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. Industry-leading advantages include a propagation delay of less than 250ps, resulting from its low channel resistance and low I/O capacitance. Its high channel-to-channel crosstalk rejection results in minimal noise interference.

### ORDERING INFORMATION

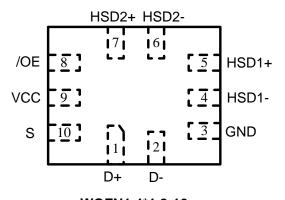
Order Number	Package Type	Temperature Range	Marking	QTY/Reel
BCT4227ETB-TR	QFN1.8x1.4-10L	-40°C to +85°C	AMX	3000
BCT4227EMB-TR	MSOP10	-40°C to +85°C	4227 XXXXX	4000

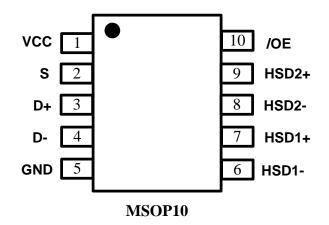
Note: "XXXXX" in Marking will be appeared as the batch code.

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### PIN CONFIGURATION (Top View)





WQFN1.4\*1.8-10

### **PIN DESCRIPTION**

Pin Number	Name	Description		
10	SEL	Select Input		
3	GND	Ground		
5 , 4	HSD1+, HSD1-	Data Ports 1		
7,6	HSD2+,HSD2-	Data Ports 2		
1 , 2	D+, D-	Data Ports		
9	VCC	Positive Power Supply		
8	/OE	Output Enable		

### LOGIC FUNCTION TABLE

/OE	SEL HSD1+,HSD1-		HSD2+,HSD2-	
1	х	OFF	OFF	
0	0	ON	OFF	
0	1	OFF	ON	



#### MAXIMUM RATINGS

Symbol	Pins	Parameter	Value	Unit	
V <sub>CC</sub>	V <sub>CC</sub>	Positive DC Supply Voltage	-0.5 to +5.25	V	
	HSD1+,				
	HSD1-,				
V <sub>IS</sub>	HSD2+,	Analog Signal Voltage	-0.5 to V <sub>CC</sub> +0.3	V	
	HSD2-				
	D+, D-		-0.5 to +5.25		
V <sub>IN</sub>	/OE	Control Input Voltage	-0.5 to +5.25	V	
Icc	Vcc	Positive DC Supply Current	50	mA	
Ts		Storage Temperature	-65 to +150	°C	
I <sub>IN</sub>	/OE	Control Input Current	±20mA	mA	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability

### **ESD PROTECTION**

Symbol	Parameter	Value	Unit
ESD	Human Body Model - All Pins	4.0	kV
ESD	Human Body Model - I/O to GND	8.0	kV



### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Pins	Parameter	Min	Мах	Unit
V <sub>cc</sub>		Positive DC Supply Voltage	1.65	4.5	V
	HSD1+,				
	HSD1-,		GND	V <sub>cc</sub>	
V <sub>IS</sub>	HSD2+,	Analog Signal Voltage			V
	HSD2-				
	D+, D-		GND	4.2	
V <sub>IN</sub>	/OE	Digital Select Input Voltage	GND	V <sub>cc</sub>	V
T <sub>A</sub>		Operating Temperature Range	-40	+85	°C

Minimum and maximum values are guaranteed through test or design across the Recommended Operating Conditions, where applicable. Typical values are listed for guidance only and are based on the particular conditions listed for section, where applicable. These conditions are valid for all values found in the characteristics tables unless otherwise specified in the test conditions.



### **DC ELECTRICAL CHARACTERISTICS** (Typical: T = 25°C)

0h.el	Disc	Demonster	Test Ose ditions	N 00	-4	0°C to +85	°C	11
Symbol	Pins	Parameter	Test Conditions	V <sub>cc</sub> (V)	Min	Тур	Max	Unit
	M	Quiescent	$V_{IS} = V_{CC}$ or GND;	1 GE 4 E			1.0	
Icc	Vcc	Supply Current	$I_{OUT} = 0 A$	1.65 -4.5	-	-	1.0	uA
		Increase in $I_{CC}$						
I <sub>CCT</sub>	V <sub>cc</sub>	per Control	$V_{IN} = 2.6 V$	3.6	-	-	10	uA
		Voltage						
	HSD1+,	OFF State						
I <sub>OZ</sub>	HSD1-, HSD2+,	Leakage	$0 \le V_{IS} \le V_{CC}$	1.65 - 4.5	-	-	±1.0	uA
	HSD2-	Current						
		Power OFF						
I <sub>OFF</sub>	D+, D-	Leakage	0 ≤ V <sub>IS</sub> ≤4.5 V	0	-	-	±1.0	uA
		Current						

#### BCT4227 SUPPLY AND LEAKAGE CURRENT

#### **BCT4227 DIGITAL INPUT VOLTAGE**

Symbol F	Dino	Parameter Test Conditions	Toot Conditions	V <sub>cc</sub> (V)	-4	Unit		
	Pins		VCC (V)	Min	Тур	Max	onn	
	S /OE	Input High		3.6	1.6			V
VIH	V <sub>IH</sub> S,/OE	Voltage		3.0	1.0	-	-	v
V		Input Low		26			0.5	V
V <sub>IL</sub> S,/0	S,/OE	Voltage		3.6	-	-	0.5	V



0h.e.l	Dia	Parameter Test Conditions	Test Conditions V (10)	-4	-40°C to +85°C			
Symbol	Pins		V <sub>cc</sub> (V)	Min	Тур	Max	Unit	
				2.7		9.0	12	
R <sub>ON</sub>		On-Resistance	$V_{\rm IS} = 0 \ V \ \text{to} \ 0.4 \ \text{V},$	3.3		8.0	10	Ω
		I <sub>ON</sub> = 8 mA	4.2		7.0	8.0		
				2.7		1.6		
R <sub>FLAT</sub>		On-Resistance		3.3		1.5		Ω
		Flatness	$I_{ON} = 8 \text{ mA}$	4.2		1.4		
		On Registeres	$\lambda = 0 \lambda to 0.4 \lambda t$	2.7		1.6		
R <sub>ON</sub>		On-Resistance	$V_{\rm IS} = 0 \ V \ \text{to} \ 0.4 \ \text{V},$	3.3		1.5		Ω
		Matching	I <sub>ON</sub> =8 mA	4.2		1.4		

#### **BCT4227 HIGH SPEED ON RESISTANCE**

### **BCT4227 DC ELECTRICAL CHARACTERISTICS**

(continued) FULL SPEED ON RESISTANCE (Typical:  $T = 25^{\circ}C$ ,  $V_{CC} = 3.3 \text{ V}$ )

Cumple of	Dine	Parameter	Test Conditions	V <sub>cc</sub> (V)	-40°C to +85°C			Unit
Symbol	Pins	Parameter		Vcc (V)	Min	Тур	Max	Unit
				2.7		9.0	12	
R <sub>ON</sub>		On-Resistance	$V_{IS} = 0 V \text{ to } V_{CC},$	3.3		8.5	10.5	Ω
			I <sub>ON</sub> = 8 mA	4.2		7.5	8.5	
		On Pasistanaa	$V_{\rm c} = 0 V_{\rm c} t_0 V_{\rm c}$	2.7		1.6		
R <sub>FLAT</sub>		On-Resistance Flatness	$V_{IS} = 0 V \text{ to } V_{CC},$ $I_{ON} = 8 \text{ mA}$	3.3		1.5		Ω
				4.2		1.4		
		On-Resistance	$V_{\rm c} = 0.V_{\rm c}$ to $V_{\rm c}$	2.7		2.20		
R <sub>ON</sub>			$V_{IS} = 0 V \text{ to } V_{CC},$	3.3		2.45		Ω
		Matching	I <sub>ON</sub> = 8 mA	4.2		2.65		

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#### **BCT4227 AC ELECTRICAL CHARACTERISTICS**

#### TIMING/FREQUENCY (Typical: T = 25°C, $V_{CC}$ = 3.3 V, $R_L$ = 50 $\Omega$ , $C_L$ = 5 pF, f = 1 MHz)

Sympol	Dino	Pins Parameter Test Conditions	V 00	-40	)°C to +85°	Ď	Unit	
Symbol	PINS	Parameter Test Condition		V <sub>cc</sub> (V)	Min	Тур	Мах	Unit
	Closed to	Turn-ON Time	Soo toot oirouit 0	1.05 4.5			20	
t <sub>ON</sub>	Open	Tum-ON Time	See test circuit 2	1.65 - 4.5		14	30	ns
+	Open to	Turn-OFF Time	See test circuit 2	1.65 - 4.5		10	20	ns
t <sub>OFF</sub>	Closed		See lest circuit 2	1.05 - 4.5		10	20	115
<b>+</b>		Break-Before-Make	See test circuit 1	1.65 - 4.5	3.0	4.4	7.0	ns
t <sub>BBM</sub>		Delay		1.05 - 4.5	3.0	4.4	7.0	115
BW		-3 dB Bandwidth	$C_L = 5 \text{ pF}$			650		MHz
Bvv			$C_L = 0 pF$	1.65 - 4.5		720		

#### BCT4227 ISOLATION

(Typical: T = 25°C,  $V_{CC}$  = 3.3 V,  $R_L$  = 50 $\Omega$ ,  $C_L$  = 5 pF)

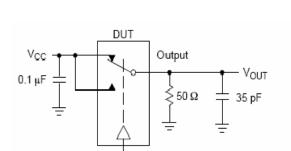
Symphol	Dine	Pins Parameter	Test Conditions	V <sub>cc</sub> (V)	-40°C to +85°C			Unit
Symbol Pin	PINS	Parameter			Min	Тур	Max	Onic
OIRR	Onen	OFF-Isolation	f = 10 MHz	1.65 -		-58		dB
UIKK	Open			4.5		-20		uБ
VTALK	HSD1+	Non-Adjacent		1.65 -		54		
XTALK	to HSD1-	Channel Crosstalk	f = 10 MHz	4.5		-54		dB

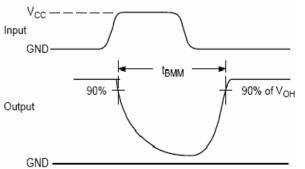


### **BCT4227 CAPACITANCE**

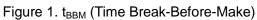
(Typical: T = 25°C,  $V_{CC}$  = 3.3 V,  $R_L$  = 50 $\Omega$  ,  $C_L$  = 5 pF, f = 1 MHz)

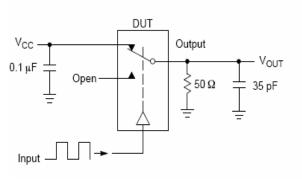
Symbol	Pins	Parameter	Test Conditions	-40°C to +85°C			
				Min	Тур	Max	- Unit
C <sub>IN</sub>	OE	Control Pin Input	N ON	-	3.0	-	pF
		Capacitance	$V_{CC} = 0 V$				
C <sub>ON</sub>	D+ to	ON Capacitance	V <sub>CC</sub> = 3.3 V; OE = 0 V	-	8.0	-	pF
	HSD1+ or						
	HSD2+						
C <sub>OFF</sub>	HSD2+,		$V_{CC} = V_{IS} = 3.3 \text{ V}; \text{ OE}$	-	4.5	-	pF
	HSD2-	OFF Capacitance	= 3.3 V				





Switch Select Pin -----





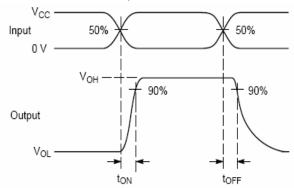
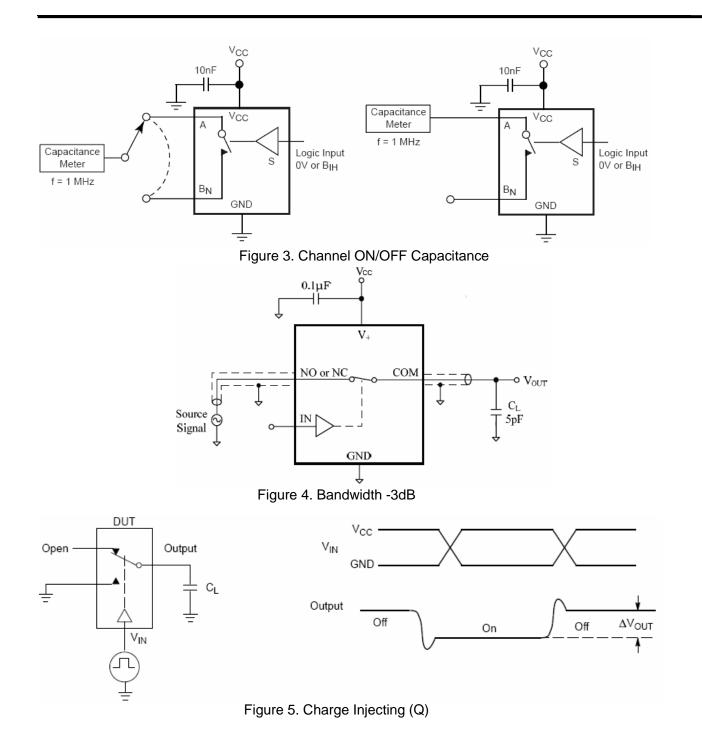


Figure 2.  $t_{ON}$  /  $t_{OFF}$ 

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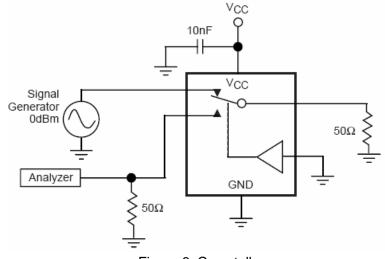


Figure 6. Crosstalk

### **Applications Information**

#### **Logic Inputs**

The logic control inputs can be driven up to +3.6V regardless of the supply voltage. For example, given a +3.3V supply, the output enables or select pins may be driven low to 0V and high to 3.6V.

### Eye Diagram Measurements

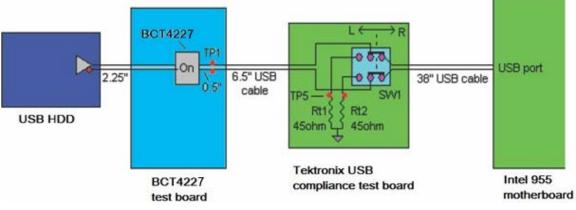


Figure 7: USB2.0 High-speed (480 Mbps) Signal Integrity Test Setup



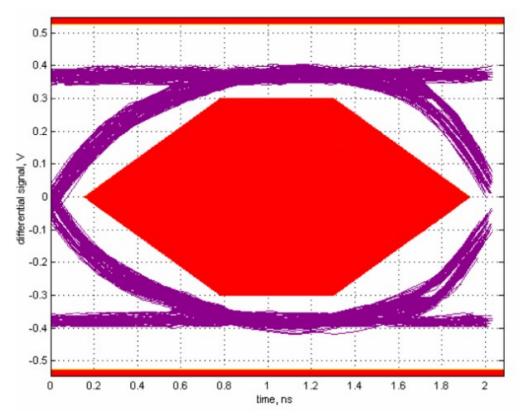


Figure 8: USB 2.0 High Speed (480Mbps) Eye Diagram Test(BCT4227 with Vcc=3.0V)



PIN 1 IDENTIFICATION

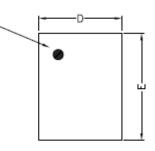
CHAMFER

BOTTOM VIEW

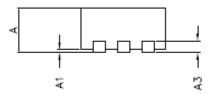
### **Package Information**

### WQFN 1.4X1.8 -10

PIN 1 DOT BY MARKING



TOP VIEW

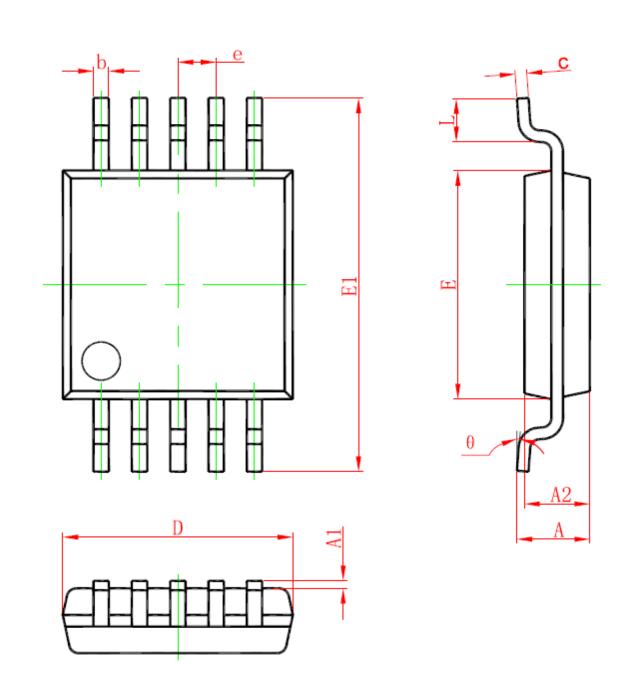


COMMON DIMENSIONS(MM)							
PKG.	UT: ULTRA THIN						
REF.	MIN.	NOM.	MAX				
A	0.50	0.55	0.60				
A1	0.00	_	0.05				
A3	0.15 REF.						
D	1.35	1.40	1.45				
E	1.75	1.80	1.85				
b	0.15	0.20	0.25				
L	0.30	0.40	0.50				
L1	0.40	0.50	0.60				
е	0.40 BSC						



# Package Information

### MSOP10





Combod a	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	0.820	1. 100	0. 032	0.043	
A1	0. 020	0. 150	0. 001	0.006	
A2	0.750	0.950	0.030	0.037	
b	0. 180	0. 280	0.007	0.011	
С	0. 090	0. 230	0.004	0.009	
D	2.900	3. 100	0. 114	0. 122	
e	0.50(BSC)		0.020(BSC)		
E	2.900	3.100	0. 114	0. 122	
E1	4. 750	5.050	0. 187	0. 199	
L	0. 400	0.800	0.016	0. 031	
θ	<b>0</b> °	6°	0°	6°	

单击下面可查看定价,库存,交付和生命周期等信息

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